

150V 4.9mohm N-channel SGT MOSFET
AKG15N049PM

Description:

This N channel SGT MOSFET has been designed to very low on-state resistance and superior UIS performance, especially for BMS application.

Features:

- Low $R_{DS(ON)}$
- Ultra-low on-resistance
- RoHS compliant ^(Note 1)
- Halogen-free ^(Note 1)
- 100% UIS tested

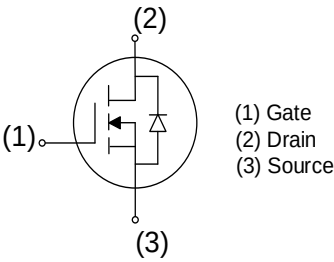
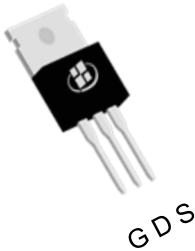
Applications:

- Battery Management System
- Motor Drivers
- DC-DC Converter

Key Performance Parameters:

Parameter	Value	Unit
V_{DS}	150	V
$R_{DS(ON), max} @V_{GS} = 10\text{ V}$	4.9	m Ω
I_D	164	A

TO-220



Ordering Information:

Ordering Code	Package Type	Marking Code	Form	Packing
AKG15N049PM	TO-220	G15N049PM	Tube	1000PCS

Notes:

1. Contact ALKAIDSEMI sales for detail information

Maximum Ratings ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Value	Units
V_{DS}	Drain-Source Voltage	150	V
I_D	Drain Current - Continuous ($T_C = 25^\circ\text{C}$) ^(Note 1)	164	A
	Drain Current - Continuous ($T_C = 100^\circ\text{C}$)	104	A
I_{DM}	Drain Current - Pulsed ^(Note 3)	530	A
V_{GS}	Gate-Source Voltage	± 20	V
E_{AS}	Single Pulsed Avalanche Energy ^(Note 4)	841	mJ
P_D	Power Dissipation ($T_C = 25^\circ\text{C}$)	277	W
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to +150	$^\circ\text{C}$

Thermal Characteristics

Symbol	Parameter	Value	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Steady-State	0.45	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Steady State ^(Note 5)	50	$^\circ\text{C/W}$

Notes:

1. The max drain current rating is silicon limited
2. The max drain current rating is package limited
3. Repetitive Rating: Pulse width limited by maximum junction temperature
4. $L = 0.5\text{ mH}$, $V_{DD} = 75\text{ V}$, $I_{AS} = 58\text{ A}$, $R_G = 50\ \Omega$, Starting $T_J = 25\ ^\circ\text{C}$
5. Mount on minimum PCB layout

Electrical Characteristics (T _J = 25°C unless otherwise noted)						
Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Static Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA	150			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 150 V, V _{GS} = 0 V,			1	μA
I _{GSS}	Gate Leakage Current	V _{GS} = ± 20 V, V _{DS} = 0 V			±100	nA
V _{GS(TH)}	Gate Threshold voltage	V _{DS} = V _{GS} , I _D = 250 μA	2	3	4	V
R _{DS(ON)}	Drain-Source on-state resistance	V _{GS} = 10 V, I _D = 20 A		4	4.9	mΩ
Dynamic Characteristics						
C _{ISS}	Input Capacitance	V _{DS} = 75 V, V _{GS} = 0 V, F = 1 MHz		8330		pF
C _{OSS}	Output Capacitance			720		pF
C _{RSS}	Reverse Transfer Capacitance			17		pF
R _G	Gate Resistance	F = 1 MHz		1.3		Ω
Switching Characteristics						
T _{D(ON)}	Turn On Delay Time	V _{DD} = 75 V , R _L = 3.75 Ω, V _{GS} = 10 V, R _G = 6.8 Ω		38		ns
T _R	Rise Time			43		ns
T _{D(OFF)}	Turn Off Delay Time			96		ns
T _F	Fall Time			43		ns
Q _G	Total Gate Charge	V _{DD} = 75 V , I _D = 20 A, V _{GS} = 10 V		116		nC
Q _{GS}	Gate-Source Charge			35		nC
Q _{GD}	Gate-Drain Charge			24		nC
Drain-Source Diode Characteristics and Maximum Ratings						
I _S	Maximum Continuous Body-Diode Forward Current				164	A
I _{SM}	Maximum Pulsed Body-Diode Forward Current ^(NOTE 1)				530	A
V _{SD}	Diode Forward Voltage	V _{GS} = 0 V, I _S = 1 A		0.62		V
T _{RR}	Reverse recovery time	V _{DD} = 75 V, I _D = 15 A, di/dt = 100 A/μS		105		ns
Q _{RR}	Reverse recovery charge			434		nC
I _{RRM}	Peak Reverse Recovery Current			7		A

Electrical Characteristics Diagrams

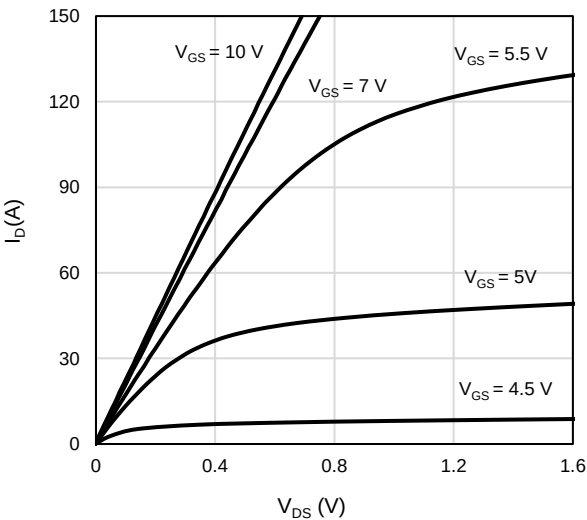


Figure 1: On-Region Characteristics

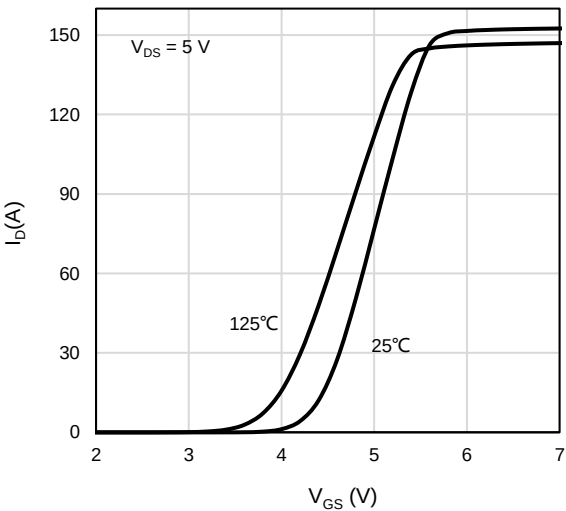


Figure 2: Transfer Characteristics

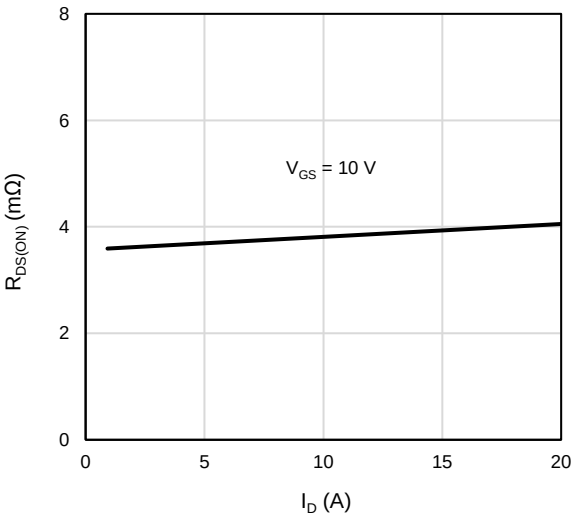


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

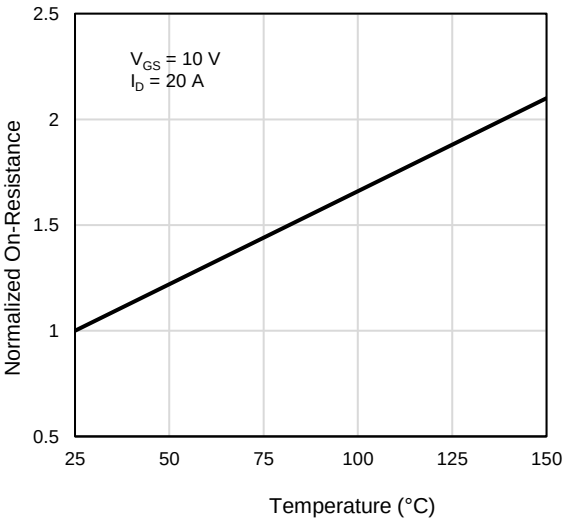


Figure 4: On-Resistance vs. Junction Temperature

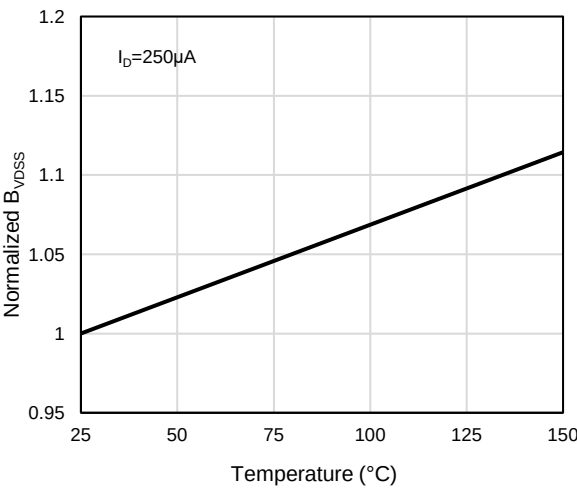


Figure 5: Breakdown Voltage vs. Junction Temperature

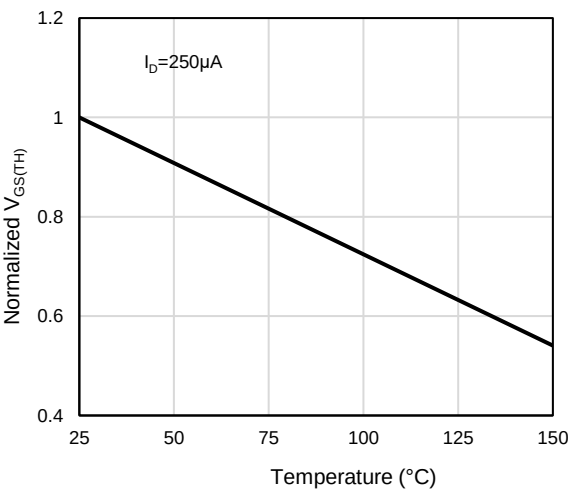


Figure 6: Threshold Voltage vs. Junction Temperature

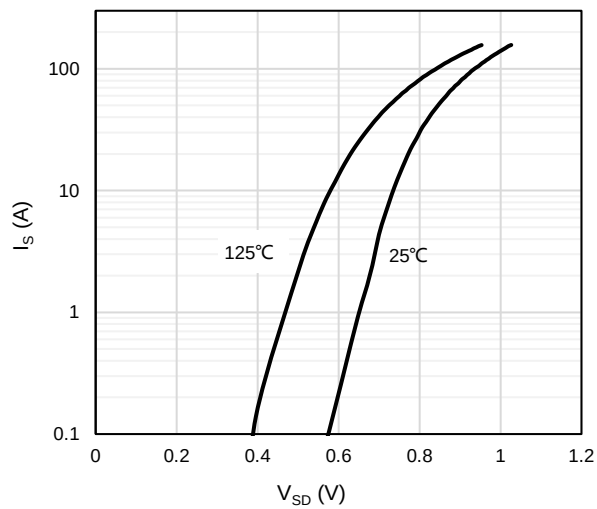


Figure 7: Body-Diode Characteristics

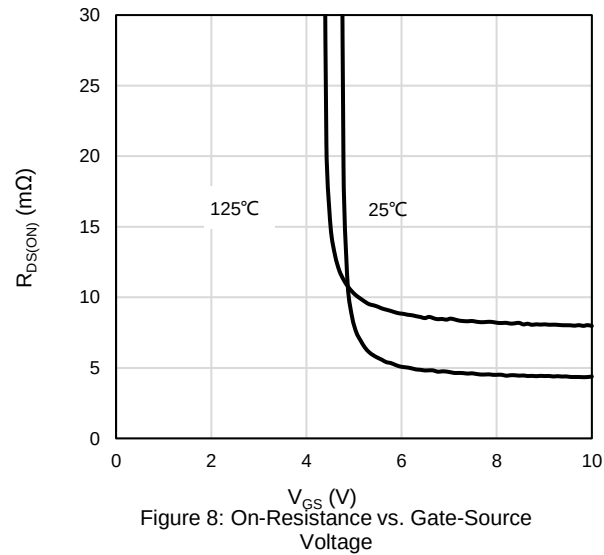


Figure 8: On-Resistance vs. Gate-Source Voltage

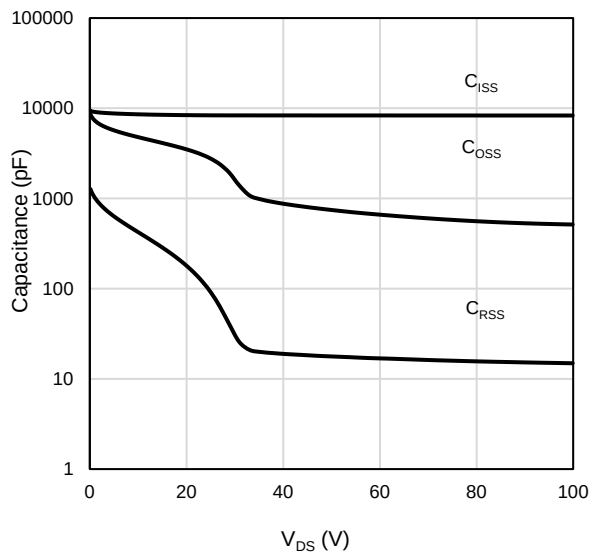


Figure 9: Capacitance Characteristics

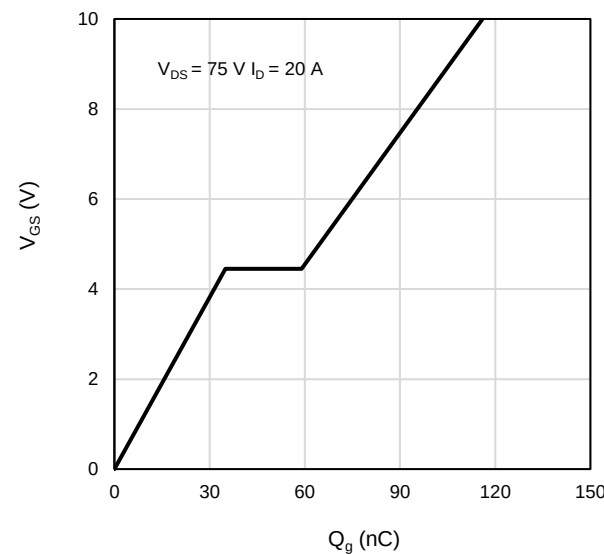


Figure 10: Gate-Charge Characteristics

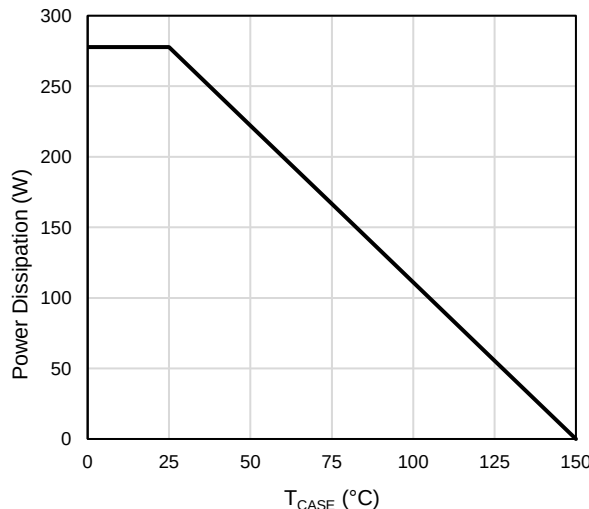


Figure 11: Power De-rating

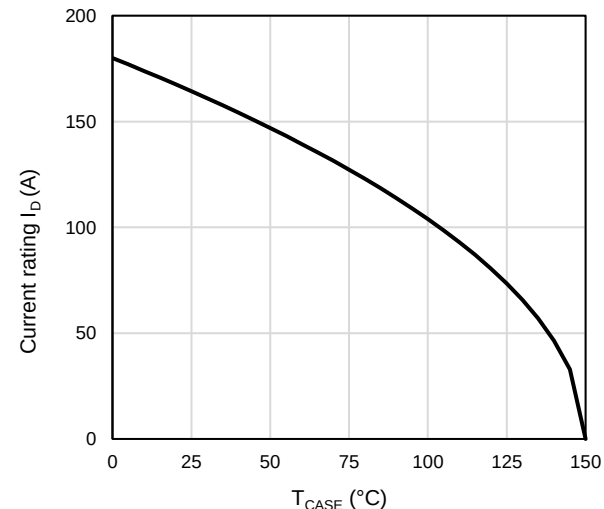


Figure 12: Current De-rating

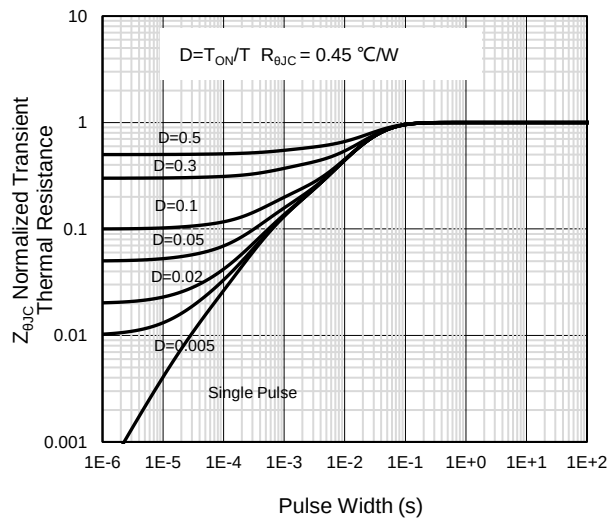


Figure 13: Normalized Maximum Transient Thermal Impedance

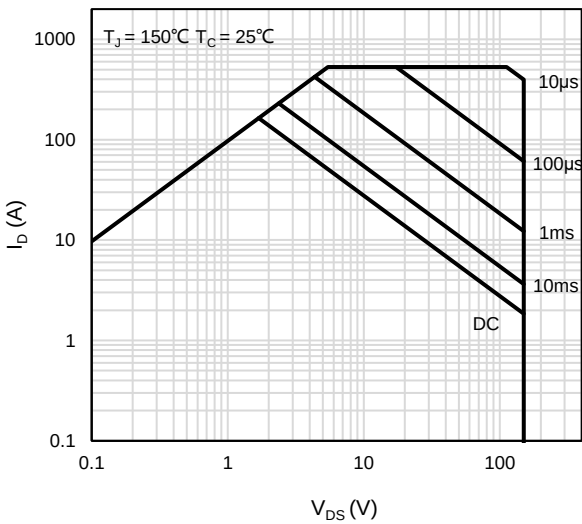
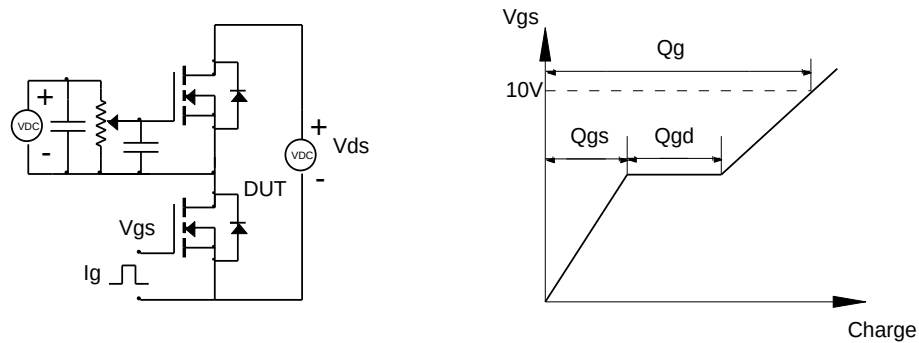


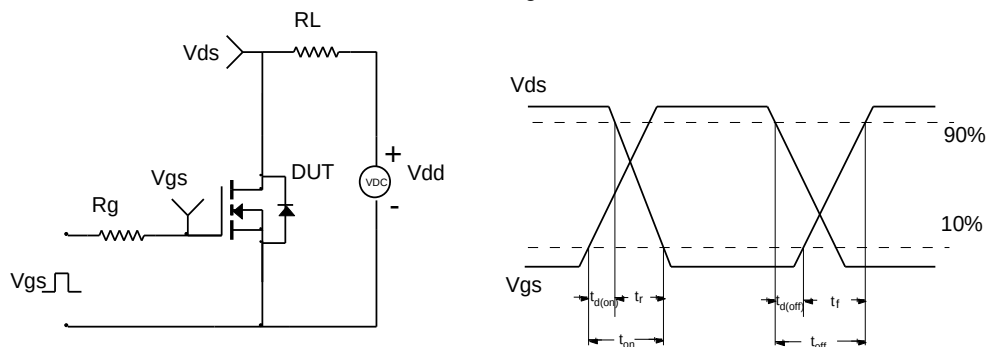
Figure 14: Maximum Forward Biased Safe Operating Area

Test Circuit and Waveform

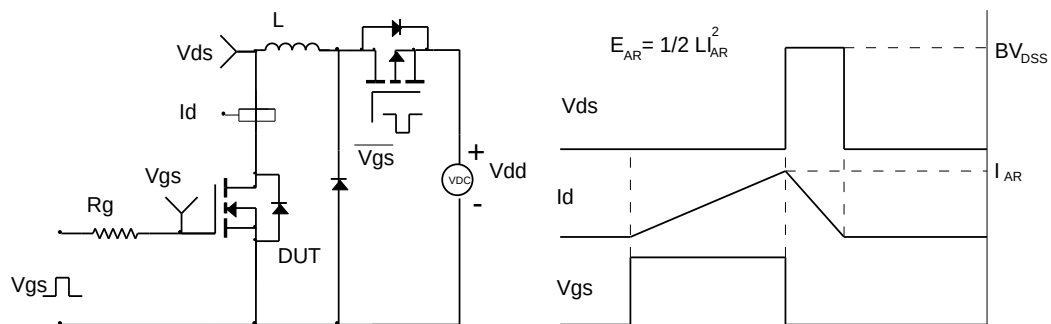
Gate Charge Test Circuit & Waveform



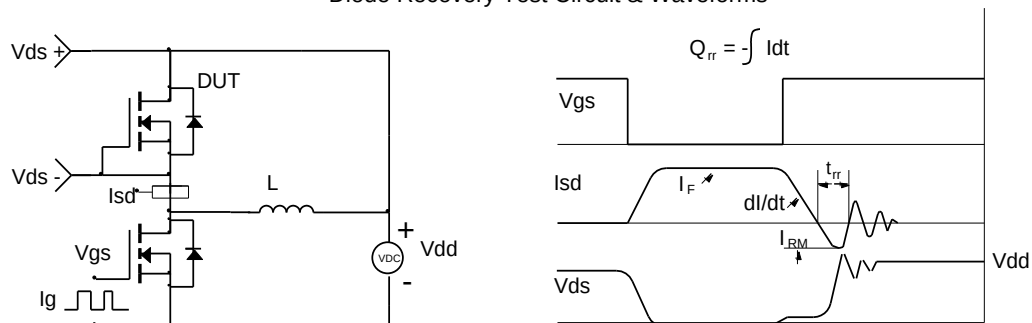
Resistive Switching Test Circuit & Waveforms



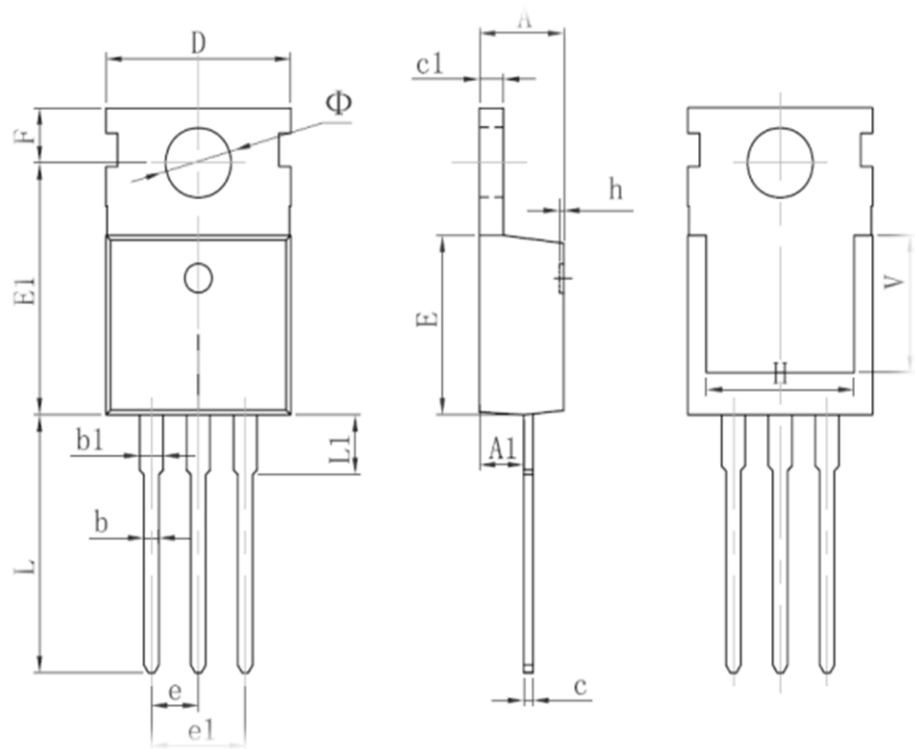
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



Package Outlines



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.400	4.600	0.173	0.181
A1	2.250	2.550	0.089	0.100
b	0.710	0.910	0.028	0.036
b1	1.170	1.370	0.046	0.054
c	0.330	0.650	0.013	0.026
c1	1.200	1.400	0.047	0.055
D	9.910	10.250	0.390	0.404
E	8.950	9.750	0.352	0.384
E1	12.650	13.050	0.498	0.514
e	2.540 TYP.		0.100 TYP.	
e1	4.980	5.180	0.196	0.204
F	2.650	2.950	0.104	0.116
H	7.900	8.100	0.311	0.319
h	0.000	0.300	0.000	0.012
L	12.900	13.400	0.508	0.528
L1	2.850	3.250	0.112	0.128
V	6.900 REF.		0.276 REF.	
Φ	3.400	3.800	0.134	0.150

Marking Information



G15N049PM
XXXXXXX

Note:

G15N049PM = Product Name Code

XXXXXXX = Date code

Contact ALKAIDSEMI sales for detail information

Revision History

Revision	Release Date	Remark
Rev.1.0	2023/5/6	Initial Release

Disclaimer

The information given in this document describes the independent performance of the product, but similar performance is not guaranteed under other working conditions, and cannot be guaranteed when installed with other products or equipment. To achieve the required performance of the product in actual scenarios, the customer should conduct a complete application test to assess the functionality of the product.

Alkaidsemi assumes no responsibility for equipment failures result from using products at values that exceed the ratings, operating conditions, or other parameters listed in the product specifications.

The product described in this specification is not applicable for aerospace or other applications which requires high reliability. Customers using or selling these products for use in medical, life-saving, or life-sustaining applications do so at their own risk and agree to fully indemnify.

Due to product or technical improvements, the information described or contained herein may be changed without prior notice.